Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/010,657	ALTHIN ET AL.
Examiner	Art Unit
Liang-che Alex Wang	2155

SEAR	CHED	
Subclass	Date	Examiner
217-219, 224, 227,229	8/21/2006	LW
		-
		-
		-
	×	
		-
	Subclass 217-219.	217-219.

INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
		-	
		100	

	DATE	EXMR
pdated Search: USPAT, USPUB, PO, JPO, DERWENT	8/21/2006	LW
•		
·		
·	·	